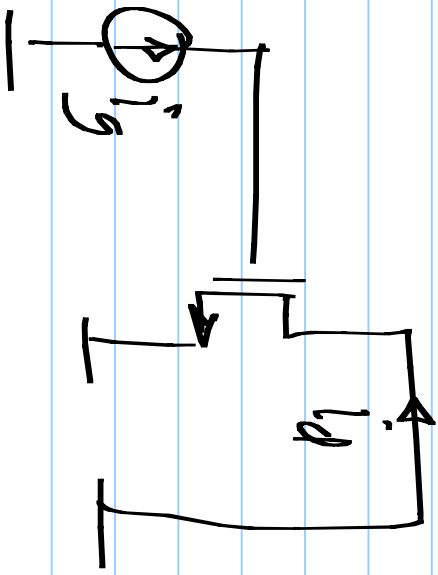


Lecture 8

21/1/2016



$$h_{21} = \frac{i_d(s)}{i_g(s)} = \frac{g_m}{sC_{gs}}$$

$$f_T = \frac{g_m}{2\pi C_{gs}}$$

Transition frequency: $\omega_T = \frac{g_m}{C_{gs}}$

$$\left| \frac{i_d}{i_g} \right|$$

-20

ω

$$A_T = \frac{g_m}{g_s} = \frac{\mu_n C_{ox} \frac{W}{L} (V_{GS} - V_T)}{\frac{2}{3} W L C_{ox}} = \frac{3}{2} \cdot \frac{\mu_n (V_{GS} - V_T)}{L^2}$$

For high speed circuits

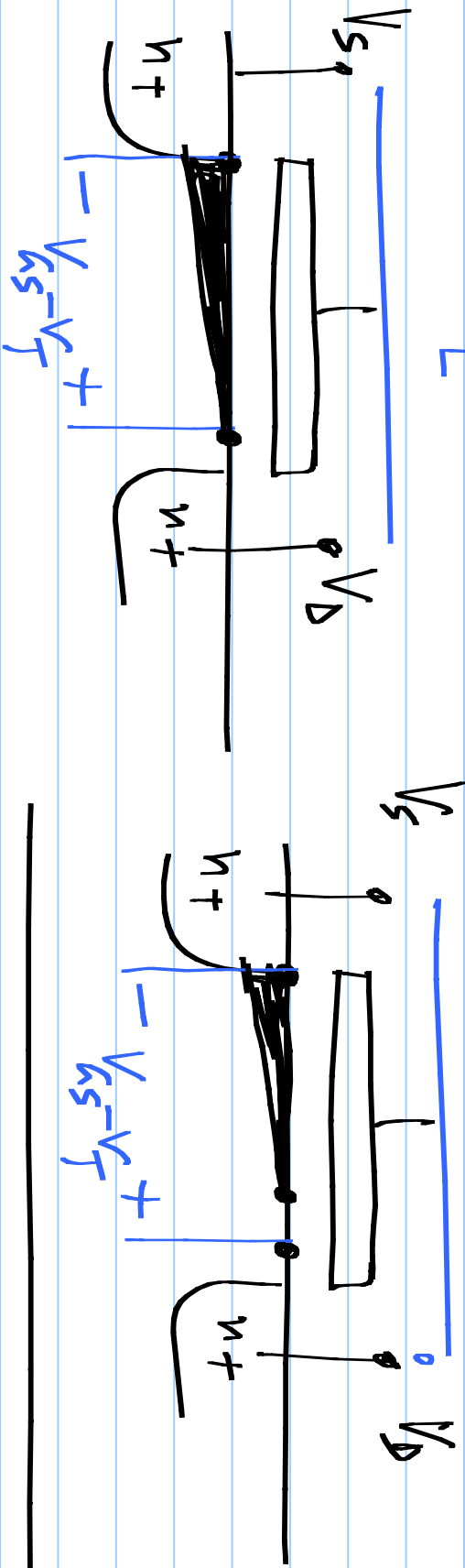
- * $nMOS$ amplifiers ($\mu_n > \mu_p$) Swing limits ↓
- * Bias @ large ($V_{GS} - V_T$) Swing limits ↓
- * Use short channel length (L) $\Rightarrow \frac{g_m}{g_s} \uparrow$ (2A)

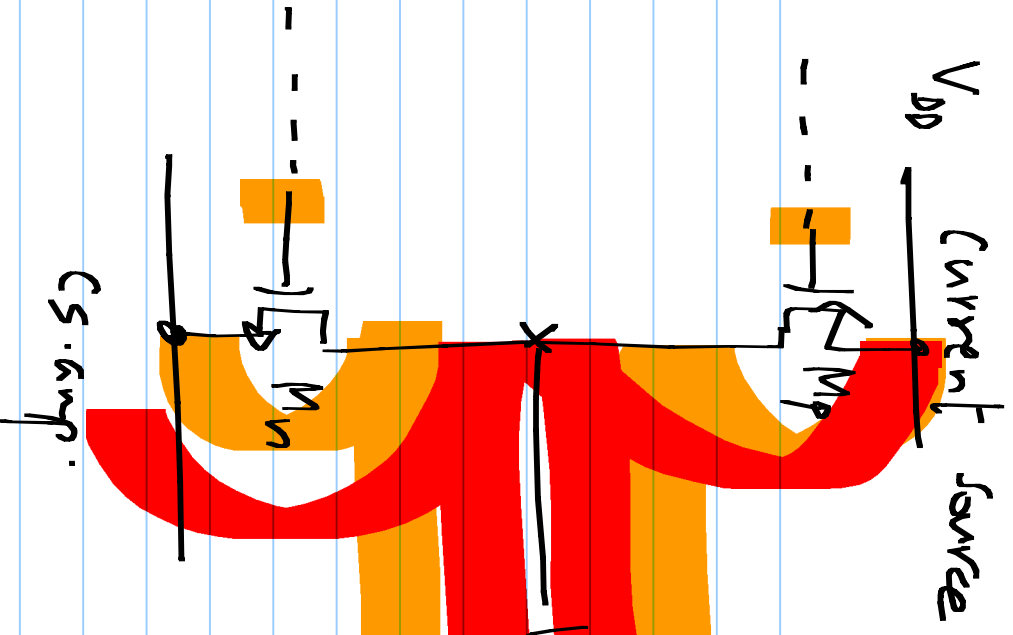
Sat. region

$$I_D = \frac{\mu_n C_{ox}}{2} \frac{W}{L} (V_{GS} - V_T)^2 (1 + \lambda V_{DS})$$

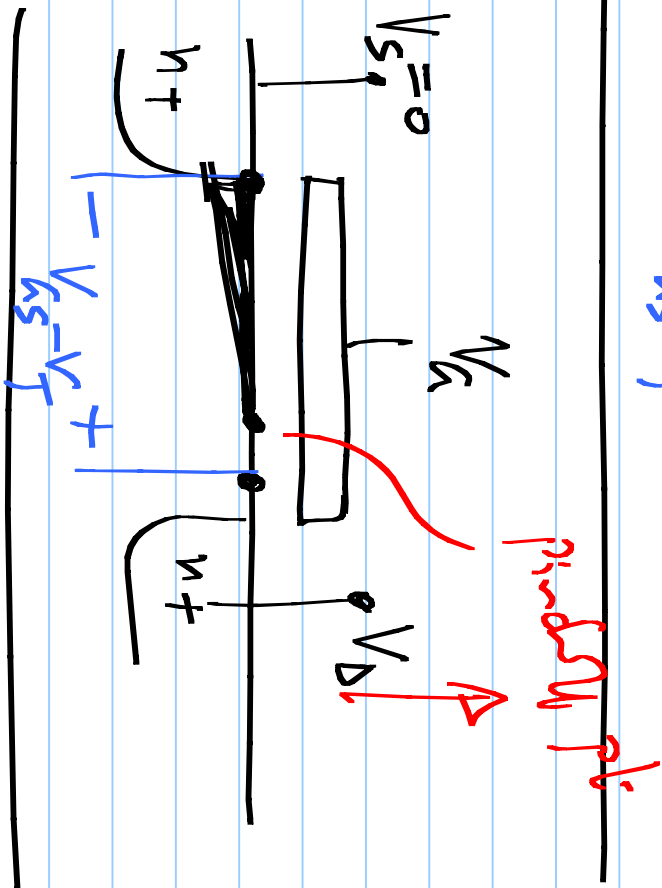
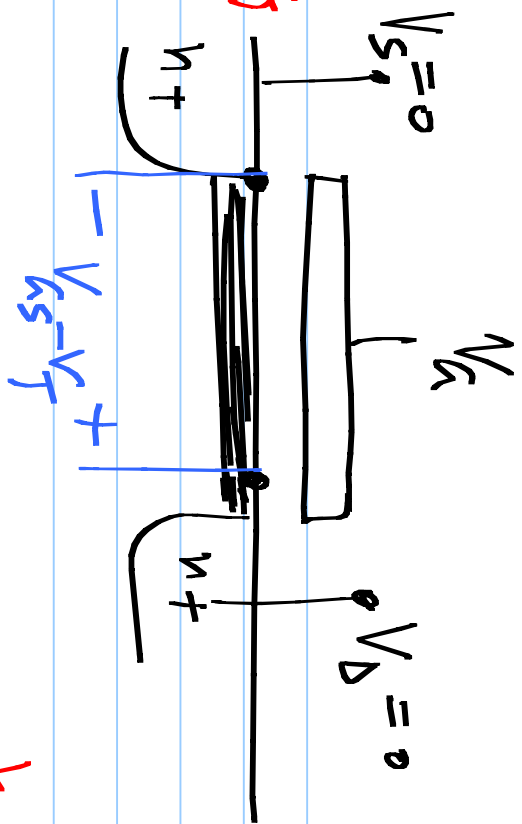
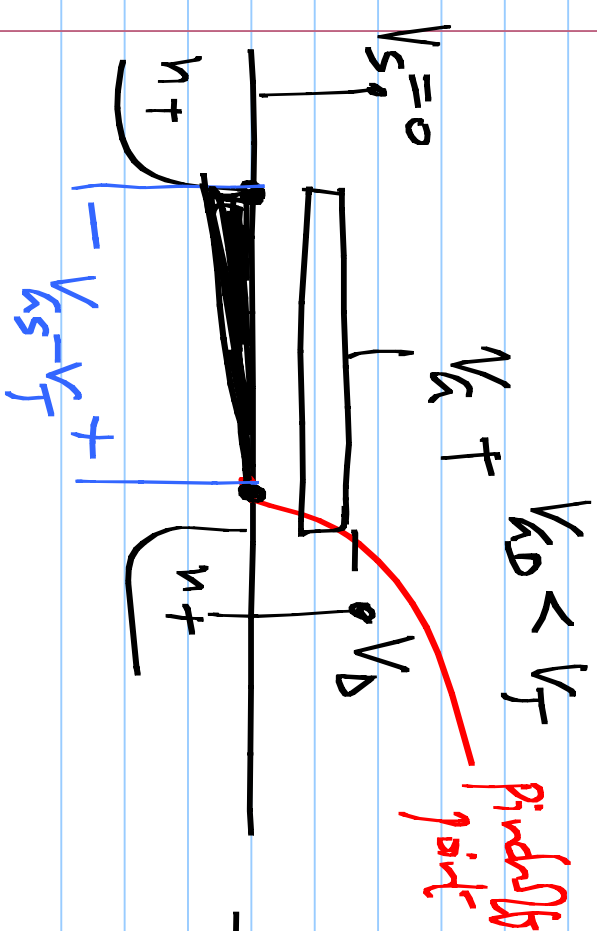
$$\lambda = \frac{K_n}{L}$$

$$\frac{W}{L} = \frac{I_D}{I_D} (1 - \delta L/L)$$





$$V_{GSn} - V_{Tn} < V_{out} < V_{DD} - (V_{Smp} - V_{Tp})$$

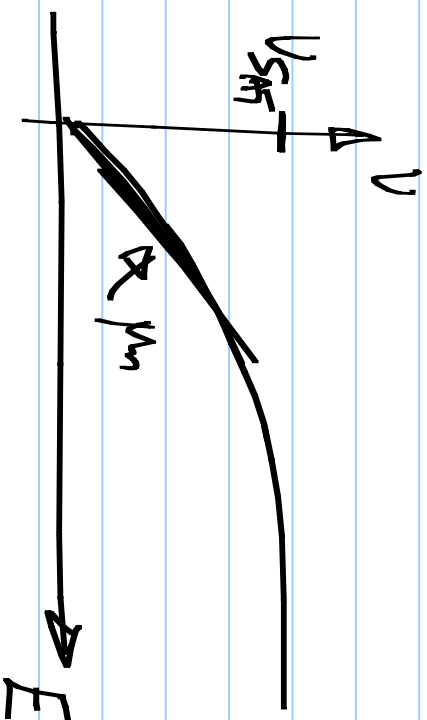


$$I_D = \frac{\mu_n C_{ox}}{2} \cdot \frac{W}{L} (V_{GS} - V_T)^2$$

Carrier velocity: $\mu_n \cdot E$

$$\mu_n \left(\frac{V_{GS} - V_T}{L} \right)$$

$$\frac{W C_{ox}}{2} \cdot (V_{GS} - V_T) \cdot V_{SAT}$$



I_D in velocity saturated region

Velocity saturation region ;

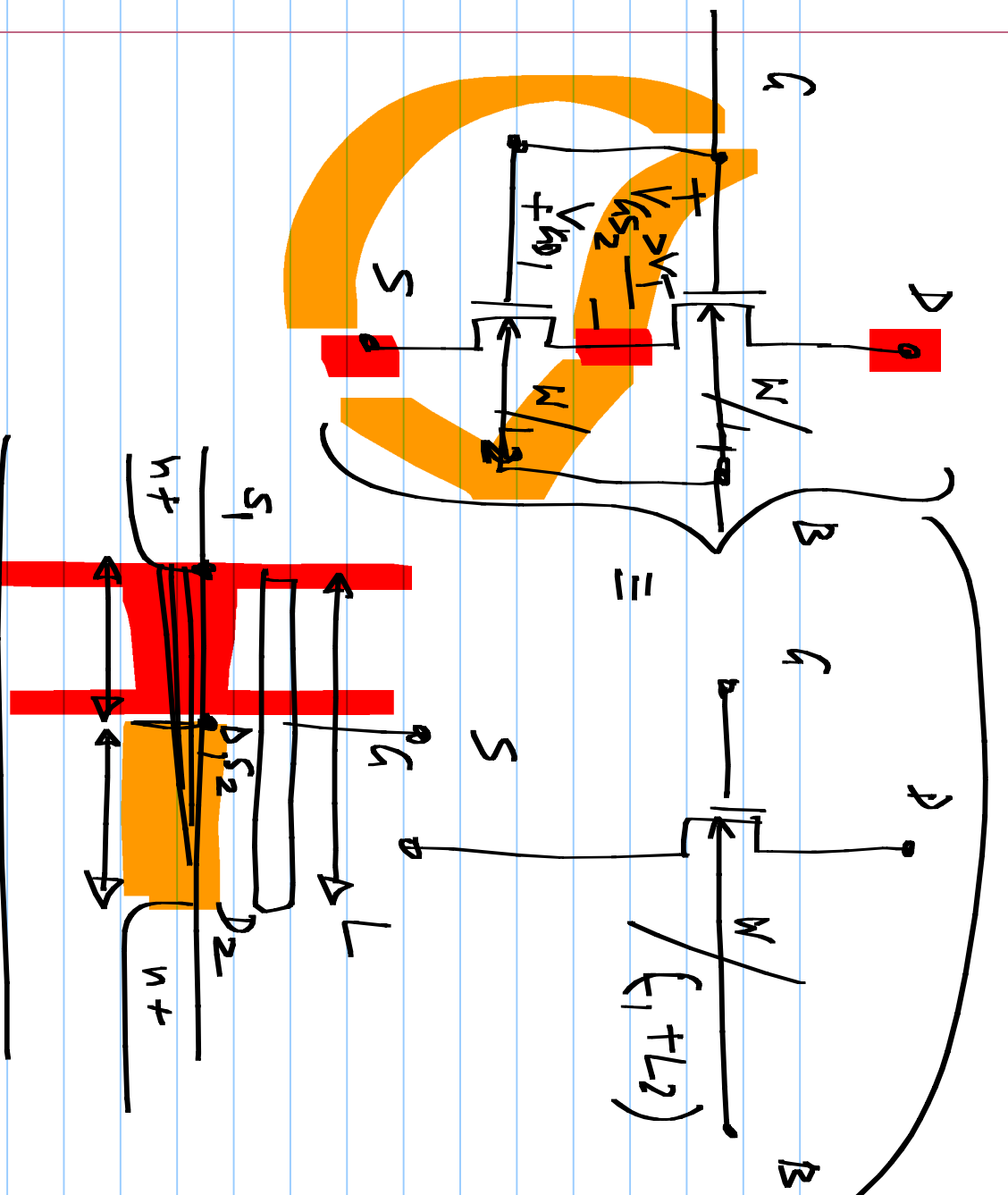
$$I_D = \frac{W C_{ox}}{2} (V_{GS} - V_T) \cdot V_{SAT}$$

} Saturation region

$$g_m = \frac{\partial I_D}{\partial V_{GS}} = \frac{W C_{ox}}{2} \cdot V_{SAT}$$

} Constant g_m

$$g_m = \frac{W C_{ox}}{2} \cdot V_{SAT} = \frac{\frac{2}{3} W L C_{ox}}{4 L} V_{SAT}$$



Series connection of $\frac{W}{L_1}$ & $\frac{W}{L_2}$

Single transistor with width W & length $L_1 + L_2$